## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10016597	HEISEY ET AL.
Examiner	Art Unit
Kiss, Eric B	2192

SEARCHED					
Class	Subclass	Date	Examine		

SEARCH NOTES				
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06/05/2007	EBK//			

	INTERFERENCE SEARCH			
Class	Subclass	Date	Examine	

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